

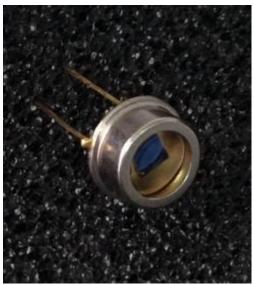
Φ8.1±0.2

Clear Glass

Disposal Nickel



Silicon Photomultiplier Detector SiPM3-VT



Description

The SiPM3-VT is a photon counting solid state replacement For photomultiplier tubers. The low dark count rates made

Rise time and short recovery time, facilitate high performance operation: both in analog/linear mode, as multi-photon detectors in which the output signal is proportional to the number of input photons, as well as in digital mode, as high speed photon counters with a wide dynamic range.

Φ9.1±0.2 NOTES: (1)Cathode ②Anode All dimension are in millimeters. Available be TO CAN(TO-5) package, combined Extremely fast

Features

- * Very low dark current
- * High speed (1ns rise time typical)
- * Wide single photon counting dynamic range (>20MHz)
- * Operating temperature is from -25 to +60 $^{\circ}$ C
- * Storage temperature is from -45 to +70 $^{\circ}$ C

Applications

- * High Energy Physics(HEP)
- * PET scanning
- * Fluorescence lifetime measurements
- * Dynamic spectrometry

* DNA sequencing

* Nuclear medicine

Information in this technical datasheet is believed to be correct and reliable. However, no responsibility is assumed for possible inaccuracies or omission. Specifications are subject change without notice

SiPM3-VT

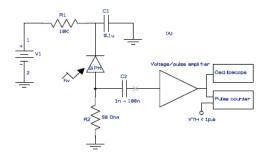
RoHS

Absolute Maximum Ratings (Ta=25 °C)

Parameter	Symbol	Condition	Min.	Тур.	Max.	Unit
Chip size	А			9		mm2
Light sensitive/Active area				196		um2
Interconnect elements	Pix	120*120 circular		14400		pixels
	pitch	Pixel ptich		25		um
	Fill factor	Per pixel	31			%
Breakdown Voltage	Vbr	-20°C, I=1nA		36		V
Vbr Temperature Coefficient	TC Vbr			50		mV/°C
Over voltage range		20°C	1		5	V
Pixel gain	Gain	Depending on overvoltage (Ubr+5V)	10 ⁵		10 ⁶	
Pixel capacitance	С			300		pF
Dark current	ID	room temperature, before breakdown			0.5	nA
Dark count rate		+20°C and Ubr+5V	400		1200	Kcps
Spectral Response Range	λ_{range}		350		1100	nm
Photon detection efficiency*	E	λ=500nm	25%			
Pulse width		FWHM	2.2	3.2	6	ns
Rise time	Tr	Up=Ubr+5V,λ=500nm	Leading edge	1		ns
Fall time	Tf		Trailing edge	1.5		ns
Single photon counting dynamic range		Comparator threshold<1 p.e.	40			MHz
Saturation power	Pmin				10	uW

^{*} PDE includes crosstalk and afterpulsing

■ Typical application circuit



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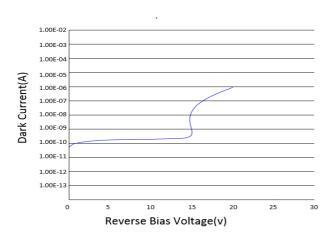
OTRON ELECTRONIC TECHNOLOGY CO., LTD

TEL:+86-21-54971821 FAX:+86-21-54971823

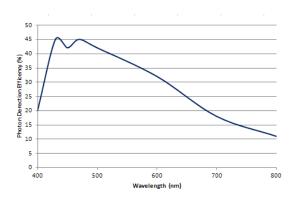




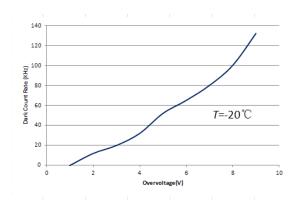
■Dark current vs. reverse voltage



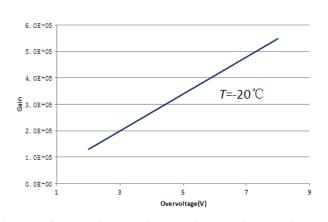
■ Photon detect efficiency vs. wavelength



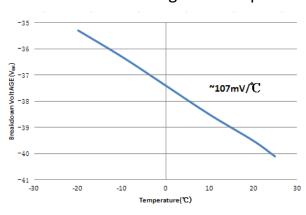
■Dark count Vs. Overbias



■Gain Vs. Overbias



■Breakdown voltage VS. Temperature



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